Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/751,372	KOERTZEN ET AL.	ΓAL.	
Examiner	Art Unit		
James K. Trujillo	2116		

SEARCHED					
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED					
Class	Subclass	Date .	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
•	DATE	EXMR		
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP	7/20/2006	JKT		
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